Supporting Information

Facile Synthesis of Mn⁴⁺-Activated Double Perovskite Germanate Phosphors with Near-Infrared Persistent Luminescence

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Figure S1. Crystal structure of La₂MgGeO₆. The Ge⁴⁺ and Mg²⁺ ions are located in octahedral units, La³⁺ ions are situated in twelve-coordinated units.



Figure S2. XRD patterns of La₂MgGeO₆ samples prepared at variable temperatures ranging from 1000 $^{\circ}$ C to 1400 $^{\circ}$ C. A comparison of the XRD patterns was made with the reference pattern La₂MgGeO₆ (ICSD No. 97016).



Figure S3. XRD patterns of La₂MgGeO₆ samples and other impurity phases. The standard XRD data of La₂O₃ (No. 01-074-2430) and La₂GeO₅ (No. 00-040-1183) are illustrated.



Figure S4. XRD patterns of La2MgGeO6 samples prepared by both SSR and MASS methods.



Figure S5. XRD patterns of La₂MgGeO₆ samples prepared by MASS method with variable reaction time.



Figure S6. Representative SEM image and SEM-EDS mappings in Mn4+-activated La2MgGeO6.



Figure S7. A comparison of the normalized photoluminescence excitation and emission spectra of La₂MgGeO₆:0.5%Mn⁴⁺ samples prepared by MASS and SSR method. Photoluminescence spectra were acquired under the same excitation at wavelength of 309 nm. Photoluminescence excitation spectra were all monitored at the same emission wavelength of 709.5 nm.



Figure S8. Excitation spectra of La₂MgGeO₆:x%Mn⁴⁺ samples with different concentrations of Mn⁴⁺(x = 0.25, 0.5, 1, 2 and 4, respectively). Excitation spectra were all monitored at the same emission wavelength of 709.5 nm.



Figure S9. Emission spectra of La₂MgGeO₆:x%Mn⁴⁺ samples with different concentrations of Mn⁴⁺ (x = 0.25, 0.5, 1, 2 and 4, respectively). Emission spectra were measured under the same excitation wavelength of 309 nm. The inset illustrates the total emission intensity as a function of Mn⁴⁺ concentration.



Figure S10. A comparison of emission intensity of La₂MgGeO₆:x%Mn⁴⁺ samples with different concentrations of Mn⁴⁺ (x = 0, 0.25, 0.5, 1, 2, 4) by using the integrating sphere.



Figure S11. A comparison of absorption efficiency of La₂MgGeO₆:x%Mn⁴⁺ samples with different concentrations of Mn⁴⁺ (x = 0, 0.25, 0.5, 1, 2, 4).



Figure S12. A comparison of internal quantum efficiency (IQE) of La₂MgGeO₆:x%Mn⁴⁺ samples with different concentrations of Mn⁴⁺ (x = 0, 0.25, 0.5, 1, 2, 4).



Figure S13. A comparison of external quantum efficiency (EQE) of La₂MgGeO₆:x Mn^{4+} samples with different concentrations of Mn^{4+} (x = 0, 0.25, 0.5, 1, 2, 4).



Figure S14. (a) Diffuse reflection spectra of the undoped La₂MgGeO₆ host, La₂MgGeO₆:1 %Mn⁴⁺ phosphor. (b) The ratio of the reflectance of 1% Mn doped La₂MgGeO₆ phosphor to the undoped La₂MgGeO₆ host.



Figure S15. A comparison of the persistent luminescence decay profiles of La2MgGeO₆:0.5%Mn⁴⁺ samples prepared by MASS and SSR method. The samples irradiated during 5-min prior to the decay measurement.



Figure S16. The emission wavelength dependent afterglow decay profiles of La₂MgGeO₆:0.5%Mn⁴⁺. The afterglow decay curves were recorded monitoring at 678, 684.5, 695.5, 705 and 709.5 nm, respectively.